2.5 V / 3.3 V, 125 MHz / 250 MHz LVDS Clock Oscillator

The NBXDPA019 dual frequency crystal oscillator (XO) is designed to meet today's requirements for 2.5 V and 3.3 V LVDS clock generation applications. The device uses a high Q fundamental crystal and Phase Lock Loop (PLL) multiplier to provide selectable 125 MHz or 250 MHz, ultra low jitter and phase noise LVDS differential output.

This device is a member of ON Semiconductor's PureEdge[™] clock family that provides accurate and precision clock solutions.

Available in 5 mm x 7 mm SMD (CLCC) package on 16 mm tape and reel in quantities of 1000.

Features

- LVDS Differential Output
- Uses High Q Fundamental Mode Crystal and PLL Multiplier
- Ultra Low Jitter and Phase Noise 0.5 ps (12 kHz 20 MHz)
- Selectable Output Frequency 125 MHz (default) / 250 MHz
- Hermetically Sealed Ceramic SMD Package
- RoHS Compliant
- Operating Range: $2.5 \text{ V} \pm 5\%$ $3.3 \text{ V} \pm 10\%$
- Total Frequency Stability ±50 ppm
- This is a Pb-Free Device

Applications

- Ethernet, Gigabit Ethernet
- Infiniband
- Base Stations

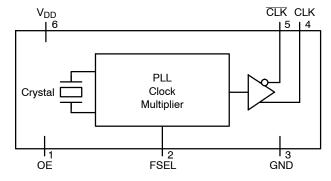


Figure 1. Simplified Logic Diagram



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6 PIN CLCC LN SUFFIX CASE 848AB



MARKING DIAGRAM

NBXDPA019 = NBXDPA019 (±50 PPM) 125/250 = Output Frequency (MHz) A = Assembly Location

WL = Wafer Lot
YY = Year
WW = Work Week
G or = Pb-Free Package

ORDERING INFORMATION

Device	Package	Shipping [†]
NBXDPA019LN1TAG	CLCC-6 (Pb-Free)	1000/ Tape & Reel
NBXDPA019LNHTAG	CLCC-6 (Pb-Free)	100/ Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

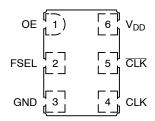


Figure 2. Pin Connections (Top View)

Table 1. PIN DESCRIPTION

Pin No.	Symbol	I/O	Description
1	OE	LVTTL/LVCMOS Control Input	Output Enable Pin. When left floating pin defaults to logic HIGH and output is active. See OE pin description Table 2.
2	FSEL	LVTTL/LVCMOS Control Input	Output Frequency Select Pin. Pin will default to logic HIGH when left open. See Output Frequency Select pin description Table 3.
3	GND	Power Supply	Ground 0 V
4	CLK	LVDS Output	Non-Inverted Clock Output. Typically loaded with 100 Ω receiver termination resistor across differential pair.
5	CLK	LVDS Output	Inverted Clock Output. Typically loaded with 100 Ω receiver termination resistor across differential pair.
6	V_{DD}	Power Supply	Positive power supply voltage. Voltage should not exceed 2.5 V $\pm 5\%$ or 3.3 V $\pm 10\%$.

Table 2. OUTPUT ENABLE TRI-STATE FUNCTION

OE Pin	Output Pins
Open	Active
HIGH Level	Active
LOW Level	High Z

Table 3. OUTPUT FREQUENCY SELECT

FSEL Pin	Output Frequency (MHz)
Open (pin will float high)	125
HIGH Level	125
LOW Level	250

Table 4. ATTRIBUTES

Characteristic		Value
Input Default State Re	sistor	170 kΩ
ESD Protection	Human Body Model Machine Model	2 kV 200 V
Meets or Exceeds JEDEC Standard EIA/JESD78 IC Latchup Test		

^{1.} For additional Moisture Sensitivity information, refer to Application Note AND8003/D.

Table 5. MAXIMUM RATINGS

Symbol	Parameter	Condition 1	Condition 2	Rating	Units	
V_{DD}	Positive Power Supply	GND = 0 V		4.6	V	
l _{out}	LVDS Output Current	Continuous Surge		25 50	mA	
T _A	Operating Temperature Range			-40 to +85	°C	
T _{stg}	Storage Temperature Range			-55 to +120	°C	
T _{sol}	Wave Solder	See Figure 6		260	°C	

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

Table 6. DC CHARACTERISTICS (V_{DD} = 2.5 V \pm 5% or V_{DD} = 3.3 V \pm 10%, GND = 0 V, T_A = -40° C to +85°C) (Note 2)

Symbol	Characteristic		Conditions	Min.	Тур.	Max.	Units
I _{DD}	Power Supply Current				78	105	mA
V _{IH}	OE and FSEL Input HIGH	Voltage		2000		V_{DD}	mV
V _{IL}	OE and FSEL Input LOW \	/oltage		GND - 300		800	mV
I _{IH}	Input HIGH Current	OE FSEL		-100 -100		+100 +100	μΑ
I _{IL}	Input LOW Current	OE FSEL		-100 -100		+100 +100	μΑ
ΔV_{OD}	Change in Magnitude of V _O Complementary Output Sta (Note 3)			0	1	25	mV
Vos	Offset Voltage			1125		1375	mV
ΔV _{OS}	Change in Magnitude of V _O Complementary Output Sta (Note 3)			0	1	25	mV
V _{OH}	Output HIGH Voltage		$V_{DD} = 2.5 \text{ V}$ $V_{DD} = 3.3 \text{ V}$		1425	1600	mV
V _{OL}	Output LOW Voltage		V _{DD} = 2.5 V V _{DD} = 3.3 V	900	1075		mV
V _{OD}	Differential Output Voltage			250		450	mV

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

^{2.} Measurement taken with outputs terminated with 100 ohm across differential pair. See Figure 5.

^{3.} Parameter guaranteed by design verification not tested in production.

Table 7. AC CHARACTERISTICS (V_{DD} = 2.5 V \pm 5% or V_{DD} = 3.3 V \pm 10%, GND = 0 V, T_A = -40°C to +85°C) (Note 4)

Symbol	Characteristic	Conditions	Min.	Тур.	Max.	Units
f _{CLKOUT}	Output Clock Frequency	FSEL = HIGH		125		MHz
		FSEL = LOW		250		1
Δf	Frequency Stability - NBXDPA019	(Note 5)			±50	ppm
Φ_{NOISE}	Phase-Noise Performance	100 Hz of Carrier		-108/-103		dBc/Hz
	f _{CLKout} = 125 MHz/250 MHz	1 kHz of Carrier		-122/-116		dBc/Hz
	(See Figures 3 and 4)	10 kHz of Carrier		-129/-123		dBc/Hz
		100 kHz of Carrier		-129/-124		dBc/Hz
		1 MHz of Carrier		-136/-131		dBc/Hz
		10 MHz of Carrier		-159/-156		dBc/Hz
t _{jit} (Φ)	RMS Phase Jitter	12 kHz to 20 MHz		0.5	0.75	ps
t _{jitter}	Cycle to Cycle, RMS	1000 Cycles		4	8	ps
	Cycle to Cycle, Peak-to-Peak	1000 Cycles		17	35	ps
	Period, RMS	10,000 Cycles		2	4	ps
	Period, Peak-to-Peak	10,000 Cycles		7	20	ps
t _{OE/OD}	Output Enable/Disable Time				200	ns
tDUTY_CYCLE	Output Clock Duty Cycle (Measured at Cross Point)		48	50	52	%
t _R	Output Rise Time (20% and 80%)			250	400	ps
t _F	Output Fall Time (80% and 20%)			250	400	ps
t _{start}	Start-up Time			1	5	ms
	Aging	1 st Year			3	ppm
		Every Year After 1st			1	ppm

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 Ifpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

- 4. Measurement taken with outputs terminated with 100 ohm across differential pair. See Figure 5.
- 5. Parameter guarantees 10 years of aging. Includes initial stability at 25°C, shock, vibration and first year aging.

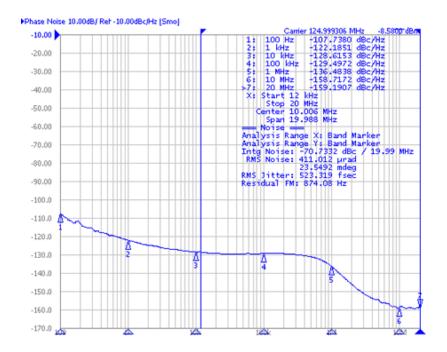


Figure 3. Typical Phase Noise Plot at 125 MHz



Figure 4. Typical Phase Noise Plot at 250 MHz

Table 8. RELIABILITY COMPLIANCE

Parameter	Standard	Method
Shock	Mechanical	MIL-STD-833, Method 2002, Condition B
Solderability	Mechanical	MIL-STD-833, Method 2003
Vibration	Mechanical	MIL-STD-833, Method 2007, Condition A
Solvent Resistance	Mechanical	MIL-STD-202, Method 215
Resistance to Soldering Heat	Mechanical	MIL-STD-203, Method 210, Condition I or J
Thermal Shock	Environment	MIL-STD-833, Method 1001, Condition A
Moisture Resistance	Environment	MIL-STD-833, Method 1004

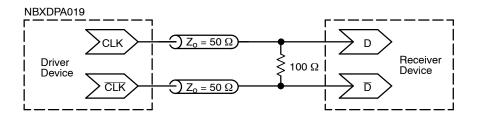


Figure 5. Typical Termination for Output Driver and Device Evaluation

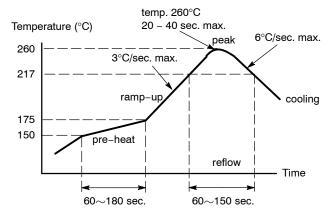
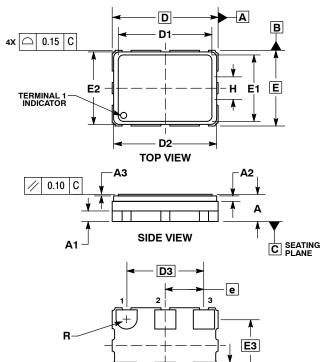


Figure 6. Recommended Reflow Soldering Profile

PACKAGE DIMENSIONS

6 PIN CLCC, 7x5, 2.54P CASE 848AB-01 ISSUE C



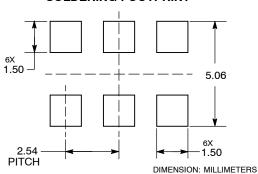
BOTTOM VIEW

NOTES

- DIMENSIONING AND TOLERANCING PER
 ASME VIA 5M 1994
- ASME Y14.5M, 1994.
 2. CONTROLLING DIMENSION: MILLIMETERS.

	MILLIMETERS			
DIM	MIN NOM MAX			
Α	1.70	1.80	1.90	
A1		0.70 REF		
A2		0.36 REF		
A3	0.08	0.10	0.12	
b	1.30	1.40	1.50	
D		7.00 BSC		
D1	6.17	6.20	6.23	
D2	6.66	6.81	6.96	
D3		5.08 BSC		
E		5.00 BSC		
E1	4.37	4.40	4.43	
E2	4.65	4.80	4.95	
E3	3.49 BSC			
е	2.54 BSC			
Н	1.80 REF			
L	1.17	1.27	1.37	
R	0.70 REF			

SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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